FAIRCHILD SEMICONDUCTOR™

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DM74ALS874B
Dual 4-Bit D-Type Edge-Triggered Flip-Flop with 3-STATE Outputs

General Description

This dual 4-bit register features totem-pole 3-STATE outputs designed specifically for driving highly-capacitive or relatively low-impedance loads. The high-impedance state and increased high-logic-level drive provide this register with the capability of being connected directly to and driving the bus lines in a bus-organized system without need for interface or pull-up components. It is particularly attractive for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The eight flip-flops of the DM74ALS874B are edge-triggered D-type flip-flops. On the positive transition of the clock, the Q outputs will be set to the logic states that were set up at the D inputs.

A buffered output control input can be used to place the eight outputs in either a normal logic state (HIGH or LOW logic levels) or a high-impedance state. In the high-impedance state the outputs neither load nor drive the bus lines significantly.

The output control does not affect the internal operation of the flip-flops. That is, the old data can be retained or new data can be entered even while the outputs are OFF.

Features

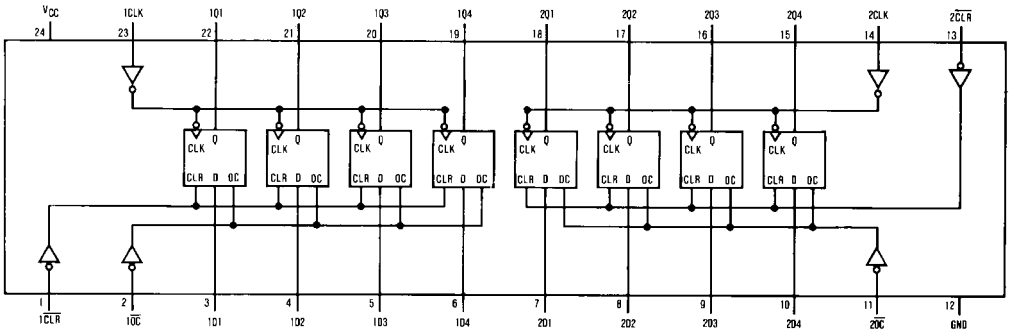
- Switching specifications at 50 pF
- Switching specifications guaranteed over full temperature and V_{CC} range
- Advanced oxide-isolated, ion-implanted Schottky TTL process
- 3-STATE buffer-type outputs drive bus lines directly
- Space saving 300 mil wide package
- Asynchronous clear

Ordering Code:

Order Number	Package Number	Package Description
DM74ALS874BWM	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
DM74ALS874BNT	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-100, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram

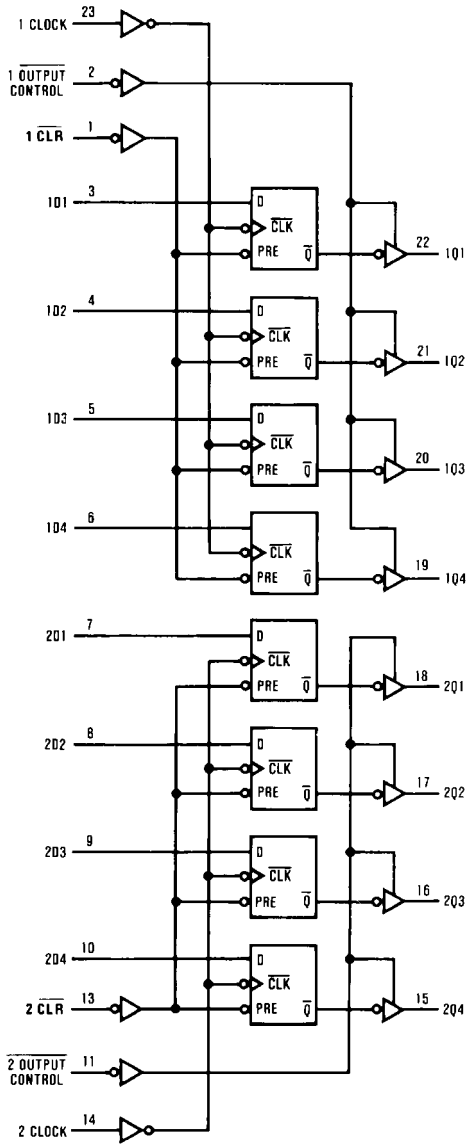


Function Table

Inputs				Output
$\overline{CLR}$	D	CLK	$\overline{OC}$	Q
X	X	X	H	Z
L	X	X	L	L
H	H	↑	L	H
H	L	↑	L	L
H	X	L	L	Q_0

L = LOW State
H = HIGH State
X = Don't Care
↑ = Positive Edge Transition
Z = High Impedance State
Q_0 = Previous Condition of Q

Logic Diagram



Absolute Maximum Ratings(Note 1)

Supply Voltage	7V
Input Voltage	7V
Voltage Applied to Disabled Output	5.5V
Operating Free Air Temperature Range	0°C to +70°C
Storage Temperature Range	−65°C to +150°C
Typical θ_{JA}	
N Package	51.0°C/W
M Package	86.5°C/W

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Parameter		Min	Nom	Max	Units
V_{CC}	Supply Voltage		4.5	5	5.5	V
V_{IH}	HIGH Level Input Voltage		2			V
V_{IL}	LOW Level Input Voltage				0.8	V
I_{OH}	HIGH Level Output Current				−2.6	mA
I_{OL}	LOW Level Output Current				24	mA
f_{CLK}	Clock Frequency		0		30	MHz
t_{WCLK}	Width of Clock Pulse	HIGH	16.5			ns
		LOW	16.5			ns
t_{WCLR}	Width of Clear Pulse	LOW	10			ns
t_{SU}	Data Setup Time (Note 2)		15↑			ns
t_H	Data Hold Time (Note 2)		0↑			ns
t_{SU}	Clear Inactive		12			ns
T_A	Free Air Operating Temperature		0		70	°C

Note 2: The (↑) arrow indicates the positive edge of the Clock is used for reference.

Electrical Characteristics

over recommended operating free air temperature range. All typical values are measured at V_{CC} = 5V, T_A = 25°C.

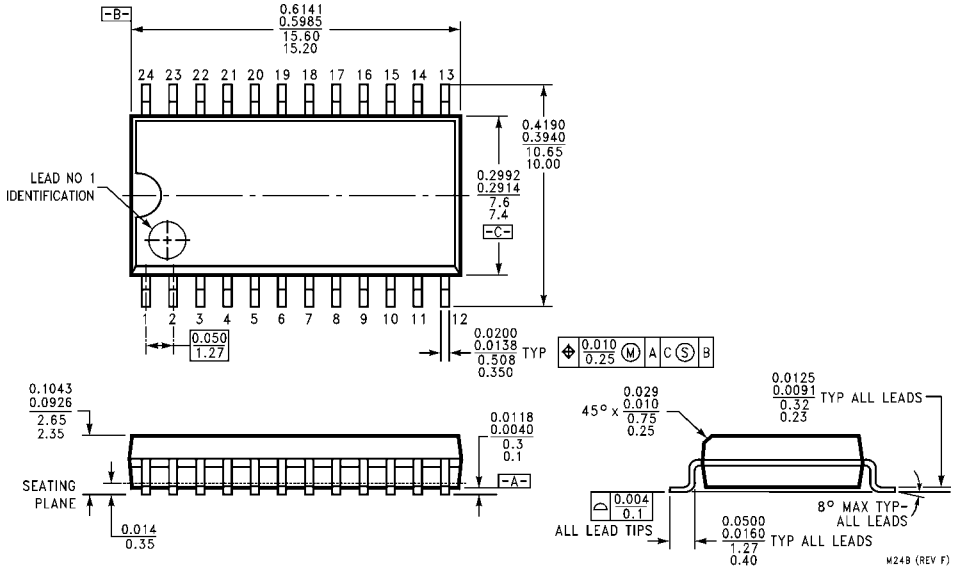
Symbol	Parameter	Conditions		Min	Typ	Max	Units
V_{IK}	Input Clamp Voltage	V_{CC} = 4.5V, I_I = −18 mA				−1.2	V
V_{OH}	HIGH Level Output Voltage	V_{CC} = 4.5V, V_{IL} = V_{IL} Max	I_{OH} = Max	2.4	3.2		V
		V_{CC} = 4.5V to 5.5V	I_{OH} = −400 µA	V_{CC} − 2			V
V_{OL}	LOW Level Output Voltage	V_{CC} = 4.5V, V_{IH} = 2V	I_{OL} = 12 mA		0.25	0.4	V
			I_{OL} = 24 mA		0.35	0.5	V
I_I	Input Current @Maximum Input Voltage	V_{CC} = 5.5V, V_{IH} = 7V				0.1	mA
I_{IH}	HIGH Level Input Current	V_{CC} = 5.5V, V_{IH} = 2.7V				20	µA
I_{IL}	LOW Level Input Current	V_{CC} = 5.5V, V_{IL} = 0.4V				−0.2	mA
I_O	Output Drive Current	V_{CC} = 5.5V, V_O = 2.25V		−30		−112	mA
I_{OZH}	OFF-State Output Current HIGH Level Voltage Applied	V_{CC} = 5.5V, V_{IH} = 2V, V_O = 2.7V				20	µA
I_{OZL}	OFF-State Output Current LOW Level Voltage Applied	V_{CC} = 5.5V, V_{IH} = 2V, V_O = 0.4V				−20	µA
I_{CC}	Supply Current	V_{CC} = 5.5V, Outputs OPEN	Outputs HIGH		14	21	mA
			Outputs LOW		19	30	mA
			Outputs Disabled		20	32	mA

Switching Characteristics

over recommended operating free air temperature range.

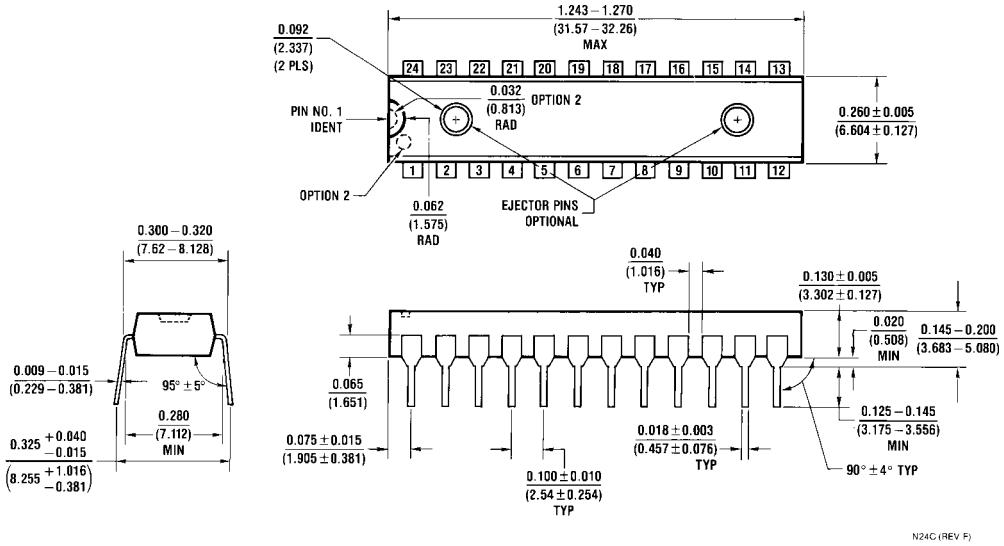
Symbol	Parameter	Conditions	From	To	Min	Max	Units
f_{MAX}	Maximum Clock Frequency	V_{CC} = 4.5V to 5.5V, R_L = 500,Ω, C_L = 50 pF			30	MHz	
t_{PLH}	Propagation Delay Time LOW-to-HIGH Level Output		Clock	Any Q	4	14	ns
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output		Clock	Any Q	4	14	ns
t_{PZH}	Output Enable Time to HIGH Level Output		Output Control	Any Q	4	18	ns
t_{PZL}	Output Enable Time to LOW Level Output		Output Control	Any Q	4	18	ns
t_{PHZ}	Output Disable Time from HIGH Level Output		Output Control	Any Q	2	10	ns
t_{PLZ}	Output Disable Time from LOW Level Output		Output Control	Any Q	3	12	ns
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output		Clear	Any Q	5	17	ns

Physical Dimensions inches (millimeters) unless otherwise noted



24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M24B

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-100, 0.300 Wide
Package Number N24C

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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